Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/849,956	382NAKANO ET AL.
Examiner	Art Unit
Chuc D. Tran	2821

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Class	Subclass	Date	Examiner
382	124	9/29/2005	тс
382	115-116	9/29/2005	TC
382	122	9/29/2005	тс

INTERFERENCE SEARCHED			
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